

DATE: January 29, 2004

SHEET 1 of 2

Form PTO - 1449 (Modified)

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 6813USDI	SERIAL NO. Application Filed Herewith
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		APPLICANT(S) Steve T. Cho	
		FILING DATE January 29, 2004	GROUP
(37 CFR 1.98 (b))			

U.S.PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	INVENTOR	CLASS	SUB CLASS	FILING DATE
CTN	A1	3,633,580	09/1969	Knox			
	A2	3,645,268	02/1972	Capote			
	A3	5,250,067	10/1993	Gelfer et al			
	A4	5,279,544	01/1994	Gross et al			
	A5	5,457,041	10/1995	Ginaven et al			
	A6	5,486,547	01/1996	Matsuda et al			
	A7	5,591,139	01/1997	Lin et al			
	A8	5,634,913	06/1997	Stinger			
	A9	5,899,915	05/1999	Saadat			
	A10	5,911,363	06/1999	Oligschlaeger			
▼	A11	5,968,022	10/1999	Saito			

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NUMBER	PUBLIC-ATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
CTN	B1	01/33614	05/10/2001	WO			
	B2	99/64580	12/16/1999	WO			
▼	B3	00/35530	06/22/2000	WO			

OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication)

C1	K. Najati,, K. D. Wise and T. Mochizuki, "a High-Yield IC-Compatible Multichannel Recording Array," IEEE Micro. Trans. On Electron Devices, vol. ED-32, pp. 1206-1211, July 1985.
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EXAMINER	CTN Nguyen	DATE CONSIDERED	3/16/05
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EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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SHEET 2 of 2

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U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO.	SERIAL NO.
		6813USD1	Application Filed Herewith
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(Use several sheets if necessary)		Steve T. Cho	
		FILING DATE	GROUP
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